

ELECTROCHEMICAL STUDY OF THE SILICON AND SILICON/CRHOMIUM PROTECTIVE FILMS ON FINEMET TYPE ALLOYS.

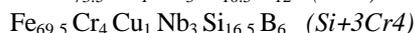
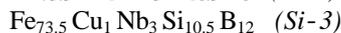
C. Tojal, A. R. Pierna, F.F. Marzo, A. Altube, M. Sistiaga, A. de Anta and A. Lorenzo.

Chemical Engineering and Environment
Dept. University of the Basque Country. P.O.Box 1379
20080 San Sebastián, SPAIN.

The amorphous metallic alloys which contain nanocrystals with lower size than a critical one, may be considered like homogeneous alloys and, sometimes, they may present a higher corrosion resistance than their respective amorphous alloys (1).

The nanocrystalline *FINEMET* alloy, can be obtained through a controlled isothermal annealing on the respective amorphous alloy, at 570K approx. (2).

In this work, the effect of the isothermal annealing at 600°C and at a temperature ($T \approx T_{onset}$) below and next to the onset temperature at which appears the peak corresponding to nanocrystallization process (obtained by DSC), on electrochemical behaviours of the metallic glasses, which compositions are as follow:



namely, type *FINEMET-Cr_x* ($x=0,4$) alloys, with different Si/B relations, have been studied.

The crystallization process alloys and their crystallization temperatures, have been analyzed by Differential Scanning Calorimetry (DSC), while the corrosion resistance of the alloys have been studied by electrochemical techniques, such as: Cyclic Voltametry (CV), and Potentiodynamic Polarization (Lineal Scanning and Corrosion Test).

The results showed that the nanocrystallized at $T \approx T_{onset}$ alloys with higher Silicon content (*Si+3* and *Si+3Cr4*), presented a better electrochemical behaviour than the respective amorphous ones. This behaviour is enhanced significantly in both alloys, when thermal annealing was carried out at 600°C, possibly due to Silicon migration towards to the surface of the alloys, as active current density data show in the *Table-I*.

However, the synergetic effect between silicon and chromium (3), in both (600°C and $T \approx T_{onset}$) isothermally annealed alloys with higher silicon content and 4 at.% of chromium (*Si+3Cr4*), improves their corrosion resistance and passivating ability due to the formation of passive films with high content in both protective elements, as it is observed in the *Figure-I*.

Acknowledgements

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References

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Alloys / State	As-Quenched	Annealed at $T \approx T_{onset}$	Annealed at 600°C
<i>Si+3</i>	64.2	51.3	0.82
<i>Si-3</i>	88.2	96	80.8
<i>Si+3Cr4</i>	1.3	0	0
<i>Si-3Cr4</i>	54.8	33.2	8

Table-I: Active current density of the alloys, as-quenched and isothermally annealed at several temperatures during 15 minutes, obtained in HCl 2N, at $v=20\text{mV}\cdot\text{min}^{-1}$.

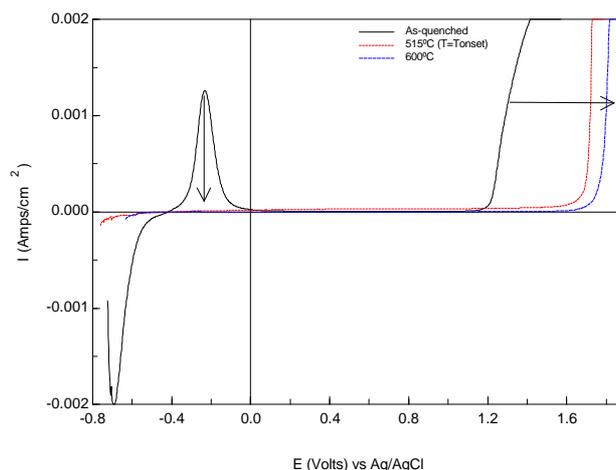


Figure-I: Potentiodynamic Polarization curves of the *Si+3Cr4* alloys, as-quenched and isothermally annealed at several temperatures during 15 minutes, obtained in HCl 2N, at $v=20\text{mV}\cdot\text{min}^{-1}$.